10/777,884	Applicant(s)/Patent Under Reexamination ZEHNLE ET AL.	
Examiner	Art Unit	
Lana N. Le	2618	Page 1 of 1
	Examiner	Examiner Art Unit

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2006/0082690	04-2006	Englert, John Watler	348/731
*	В	US-2004/0044902	03-2004	Luthi, Peter O.	713/200
*	U	US-2003/0083054	05-2003	Francesca et al.	455/418
*	ם	US-6,748,237	06-2004	Bates et al.	455/186.1
	ш	US-			
	F	US-			
	G	US-			
	I	US-			
	_	US-			
	7	US-			
	ĸ	US-			
	١	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N.					
	0					
	Р			·		
	Q					
	R					
	s					
	Т	·				

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	·
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.